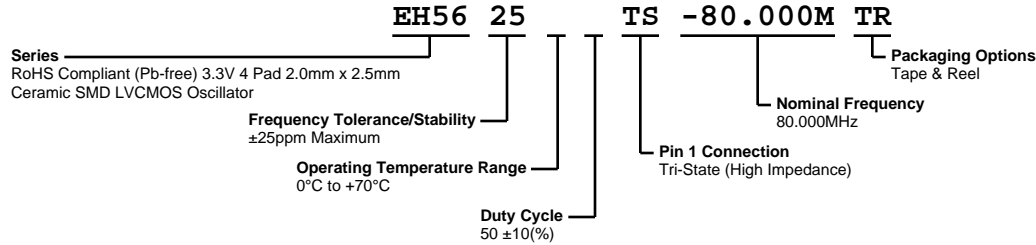


# EH5625TS-80.000M TR



## ELECTRICAL SPECIFICATIONS

|  |   |
|--|---|
| <b>Nominal Frequency</b>                     | 80.000MHz   |
| <b>Frequency Tolerance/Stability</b>         | $\pm 25$ ppm Maximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°, 260°C Reflow, Shock, and Vibration) |
| <b>Aging at 25°C</b>                         | $\pm 5$ ppm/Year Maximum  |
| <b>Operating Temperature Range</b>           | 0°C to +70°C  |
| <b>Supply Voltage</b>                        | 3.3Vdc $\pm 5\%$  |
| <b>Input Current</b>                         | 13mA Maximum (No Load)  |
| <b>Output Voltage Logic High (Voh)</b>       | 90% of Vdd Minimum (IOH = -8mA)   |
| <b>Output Voltage Logic Low (Vol)</b>        | 10% of Vdd Maximum (IOL = +8mA)   |
| <b>Rise/Fall Time</b>                        | 2nSec Maximum (Measured at 20% to 80% of waveform)  |
| <b>Duty Cycle</b>                            | 50 $\pm$ 10(%) (Measured at 50% of waveform)  |
| <b>Load Drive Capability</b>                 | 15pF Maximum  |
| <b>Output Logic Type</b>                     | CMOS  |
| <b>Pin 1 Connection</b>                      | Tri-State (High Impedance)  |
| <b>Tri-State Input Voltage (Vih and Vil)</b> | 90% of Vdd Minimum or No Connect to Enable Output, 10% of Vdd Maximum to Disable Output (High Impedance)  |
| <b>Standby Current</b>                       | 10 $\mu$ A Maximum (Pin 1 = Ground)   |
| <b>Absolute Clock Jitter</b>                 | $\pm 100$ pSec Maximum  |
| <b>Start Up Time</b>                         | 10mSec Maximum  |
| <b>Storage Temperature Range</b>             | -55°C to +125°C   |

## ENVIRONMENTAL & MECHANICAL SPECIFICATIONS

|                                     |   |
|-------------------------------------|---|
| <b>ESD Susceptibility</b>           | MIL-STD-883, Method 3015, Class 1, HBM: 1500V |
| <b>Fine Leak Test</b>               | MIL-STD-883, Method 1014, Condition A         |
| <b>Flammability</b>                 | UL94-V0                                       |
| <b>Gross Leak Test</b>              | MIL-STD-883, Method 1014, Condition C         |
| <b>Mechanical Shock</b>             | MIL-STD-883, Method 2002, Condition B         |
| <b>Moisture Resistance</b>          | MIL-STD-883, Method 1004                      |
| <b>Moisture Sensitivity</b>         | J-STD-020, MSL 1                              |
| <b>Resistance to Soldering Heat</b> | MIL-STD-202, Method 210, Condition K          |
| <b>Resistance to Solvents</b>       | MIL-STD-202, Method 215                       |
| <b>Solderability</b>                | MIL-STD-883, Method 2003                      |
| <b>Temperature Cycling</b>          | MIL-STD-883, Method 1010, Condition B         |
| <b>Vibration</b>                    | MIL-STD-883, Method 2007, Condition A         |

# EH5625TS-80.000M TR

## MECHANICAL DIMENSIONS (all dimensions in millimeters)



| PIN | CONNECTION     |
|-----|----------------|
| 1   | Tri-State      |
| 2   | Ground         |
| 3   | Output         |
| 4   | Supply Voltage |

| LINE | MARKING  |
|------|--|
| 1    | <b>EPO</b>   |
| 2    | <b>XXXXX</b><br>XXXXX=Ecliptek<br>Manufacturing Code |

## Suggested Solder Pad Layout

All Dimensions in Millimeters



All Tolerances are  $\pm 0.1$

# EH5625TS-80.000M TR

## OUTPUT WAVEFORM & TIMING DIAGRAM



### Test Circuit for CMOS Output



Note 1: An external 0.1 $\mu$ F low frequency tantalum bypass capacitor in parallel with a 0.01 $\mu$ F high frequency ceramic bypass capacitor close to the package ground and  $V_{DD}$  pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value  $C_L$  includes sum of all probe and fixture capacitance.

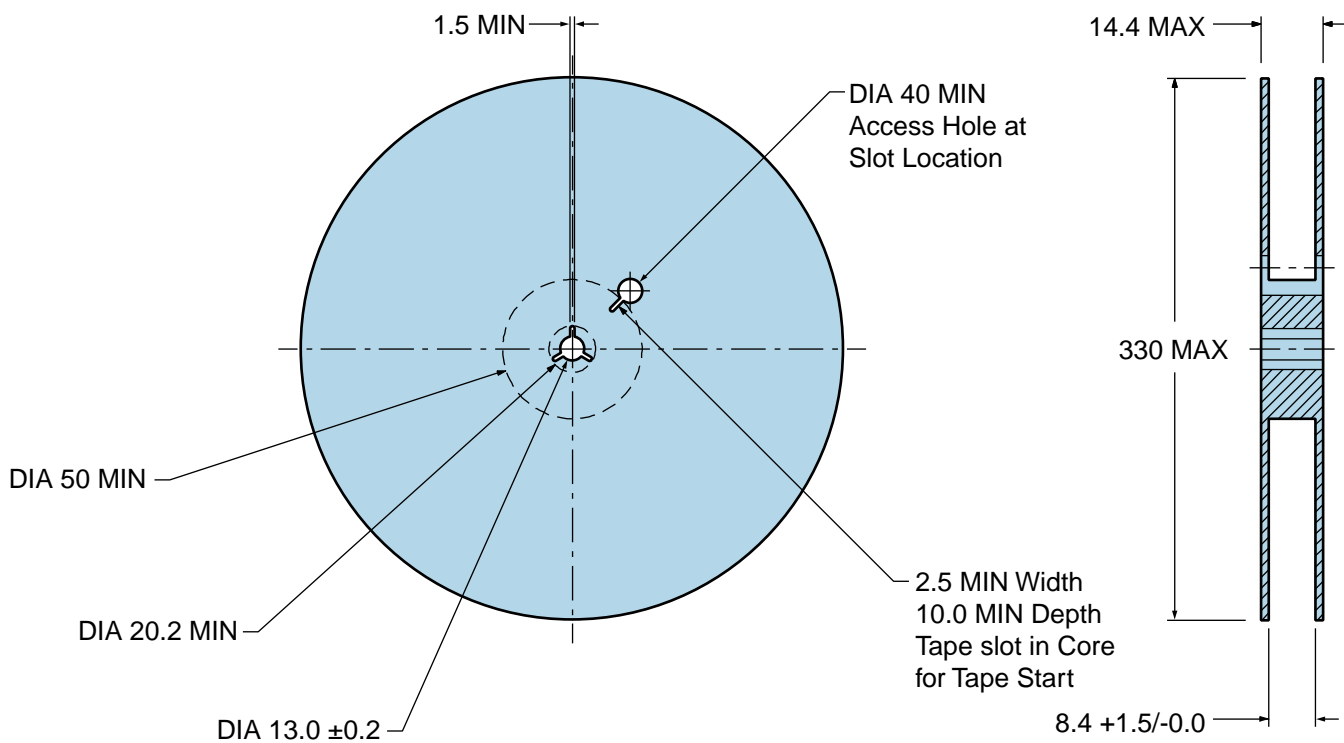
# EH5625TS-80.000M TR

## Tape & Reel Dimensions

Quantity Per Reel: 1,000 units



\*Compliant to EIA 481A



## Recommended Solder Reflow Methods



### High Temperature Infrared/Convection

|  |                                      |
|--|--------------------------------------|
| <b>T<sub>s</sub> MAX to T<sub>L</sub> (Ramp-up Rate)</b> | 3°C/second Maximum                   |
| <b>Preheat</b>   |                                      |
| - Temperature Minimum (T <sub>s</sub> MIN)               | 150°C                                |
| - Temperature Typical (T <sub>s</sub> TYP)               | 175°C                                |
| - Temperature Maximum (T <sub>s</sub> MAX)               | 200°C                                |
| - Time (t <sub>s</sub> MIN)                              | 60 - 180 Seconds                     |
| <b>Ramp-up Rate (T<sub>L</sub> to T<sub>p</sub>)</b>     | 3°C/second Maximum                   |
| <b>Time Maintained Above:</b>                            |                                      |
| - Temperature (T <sub>L</sub> )                          | 217°C                                |
| - Time (t <sub>L</sub> )                                 | 60 - 150 Seconds                     |
| <b>Peak Temperature (T<sub>p</sub>)</b>                  | 260°C Maximum for 10 Seconds Maximum |
| <b>Target Peak Temperature (T<sub>p</sub> Target)</b>    | 250°C +0/-5°C                        |
| <b>Time within 5°C of actual peak (t<sub>p</sub>)</b>    | 20 - 40 seconds                      |
| <b>Ramp-down Rate</b>                                    | 6°C/second Maximum                   |
| <b>Time 25°C to Peak Temperature (t)</b>                 | 8 minutes Maximum                    |
| <b>Moisture Sensitivity Level</b>                        | Level 1                              |

## Recommended Solder Reflow Methods



### Low Temperature Infrared/Convection 240°C

|  |  |
|--|--|
| <b>T<sub>S</sub> MAX to T<sub>L</sub> (Ramp-up Rate)</b> | 5°C/second Maximum                                     |
| <b>Preheat</b>   |  |
| - Temperature Minimum (T <sub>S</sub> MIN)               | N/A  |
| - Temperature Typical (T <sub>S</sub> TYP)               | 150°C  |
| - Temperature Maximum (T <sub>S</sub> MAX)               | N/A  |
| - Time (t <sub>S</sub> MIN)                              | 60 - 120 Seconds                                       |
| <b>Ramp-up Rate (T<sub>L</sub> to T<sub>P</sub>)</b>     | 5°C/second Maximum                                     |
| <b>Time Maintained Above:</b>                            |  |
| - Temperature (T <sub>L</sub> )                          | 150°C  |
| - Time (t <sub>L</sub> )                                 | 200 Seconds Maximum                                    |
| <b>Peak Temperature (T<sub>P</sub>)</b>                  | 240°C Maximum  |
| <b>Target Peak Temperature (T<sub>P</sub> Target)</b>    | 240°C Maximum 1 Time / 230°C Maximum 2 Times           |
| <b>Time within 5°C of actual peak (t<sub>p</sub>)</b>    | 10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time |
| <b>Ramp-down Rate</b>                                    | 5°C/second Maximum                                     |
| <b>Time 25°C to Peak Temperature (t)</b>                 | N/A  |
| <b>Moisture Sensitivity Level</b>                        | Level 1  |

### Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

### High Temperature Manual Soldering

260°C Maximum for 5 seconds Maximum, 2 times Maximum.